

**Search Notes**

Application/Control No.

10/826,962

Examiner

TAN TRINH

Applicant(s)/Patent under  
Reexamination

SEKI ET AL.

Art Unit

2684

**SEARCHED**

Class	Subclass	Date	Examiner
455	450	5/22/2006	TT
	522		
	69		
	67.1		
	422		
	452.2		
	509		
	560		
	437		
	439		
	436		
370	335		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	5/22/2006	TT
NGUYEN VO	5/22/2006	TT